

60V N-Channel Enhancement Mode Power MOSFET

General Description

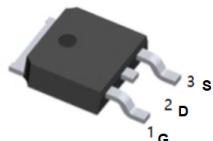
The STD35NF06 uses advanced trench technology and design to provide excellent $R_{DS(ON)}$ with low gate charge. It can be used in a wide variety of applications.

Features

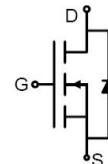
- $V_{DS} = 60V, ID = 35A$
- $R_{DS(ON)}, 20m\Omega$ (Typ) @ $V_{GS} = 10V$
- $R_{DS(ON)}, 16m\Omega$ (Typ) @ $V_{GS} = 4.5V$
- Advanced Trench Technology
- Excellent $R_{DS(ON)}$ and Low Gate Charge
- Lead free product is acquired

Application

- Load Switch
- PWM Application
- Power management



TO-252(DPAK) top view



Schematic Diagram

Absolute Maximum Ratings(TA=25°C unless otherwise noted)

Parameter		Symbol	Value	Unit
Drain-Source Voltage		V_{DS}	60	V
Gate-Source Voltage		V_{GS}	± 20	V
Drain Current-Continuous ^{Note3}	TC=25°C		35	A
	TC=100°C		25	A
Drain Current-Pulsed ^{Note1}		I_{DM}	140	A
Avalanche Energy ^{Note4}		E_{AS}	72	mJ
Maximum Power Dissipation	TC=25°C	P_D	105	W
Storage Temperature Range		T_{STG}	-55 to +150	°C
Operating Junction Temperature Range		T_J	-55 to +150	°C

Thermal Resistance

Parameter	Symbol	Min.	Typ.	Max	Unit
Thermal Resistance,Junction-to-Case	$R_{\theta JC}$	-	-	1.4	°C/W

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Electrical Characteristics(TJ=25°C unless otherwise noted)

OFF CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V,I _{DS} =250uA	60	-	-	V
Zero Gate Voltage Drain Current	I _{DSS}	V _{DS} =60V,V _{GS} =0V	-	-	1.0	uA
Gate-Body Leakage	I _{GSS}	V _{GS} =±20V,V _{DS} =0V	-	-	±100	nA

ON CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Gate Threshold Voltage	V _{GS(TH)}	V _{DS} =V _{GS} ,I _{DS} =250uA	2	3	4	V
Drain-Source On-State Resistance	R _{DS(ON)}	V _{GS} =10V,I _{DS} =30A	-	12	20	mΩ
		V _{GS} =4.5V,I _{DS} =20A	-	16		mΩ

DYNAMIC CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Input Capacitance	C _{iss}	V _{DS} =25V, V _{GS} = 0V, f=1MHz	-	1300	-	pF
Output Capacitance	C _{oss}		-	300	-	
Reverse Transfer Capacitance	C _{rss}		-	105	-	

SWITCHING CHARACTERISTICS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Turn-On Delay Time	T _{d(on)}	V _{GS} =10V,V _{DS} =30V, R _{GEN} =4.7Ω I _D =27.5A	-	20	-	ns
Rise Time	t _r		-	50	-	
Turn-Off Delay Time	T _{d(off)}		-	36	-	
Fall Time	t _f		-	15	-	
Total Gate Charge at 10V	Q _g	V _{DS} =30V,I _{DS} =55A, V _{GS} =10V	-	44.5	60	nC
Gate to Source Gate Charge	Q _{gs}		-	10.5	-	
Gate to Drain "Miller" Charge	Q _{gd}		-	17.5	-	

DRAIN-SOURCE DIODE CHARACTERISTICS AND MAXIMUM RATINGS						
Parameter	Symbol	Conditions	Min.	Typ.	Max.	Unit
Drain-Source Diode Forward Voltage	V _{SD}	V _{GS} =0V,I _{DS} =35A	-	-	1.5	V
Reverse Recovery Time	t _{rr}	T _J =25°C, I _F =25A di/dt=100A/us	-	75	-	nS
Reverse Recovery Charge	Q _{rr}		-	170	-	uC

Notes:

- 1: Repetitive rating, pulse width limited by maximum junction temperature.
- 2: Surface mounted on FR4 Board, t≤10sec.
- 3: Pulse width ≤ 300μs, duty cycle ≤ 2%.
- 4: EAS condition: L=0.5mH,VDD=10V,VG=10V,V_{GATE}=20V,Start T_J=25°C.

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Figure 1: Output Characteristics

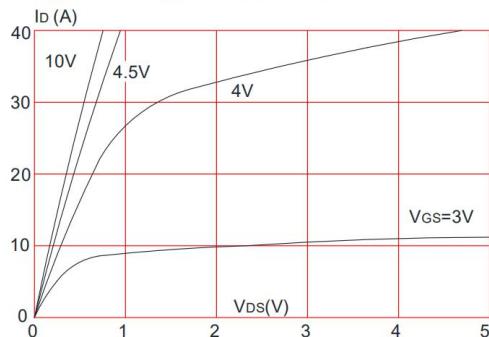


Figure 2: Typical Transfer Characteristics

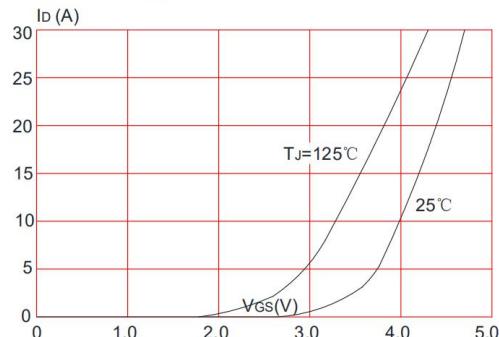


Figure 3: On-resistance vs. Drain Current

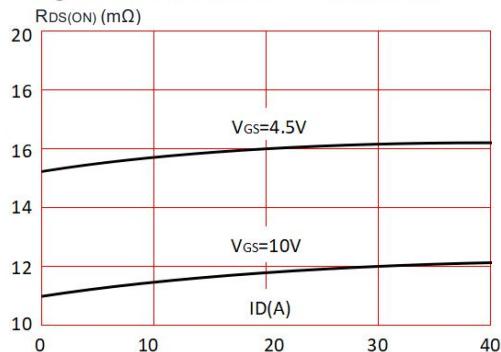


Figure 4: Body Diode Characteristics

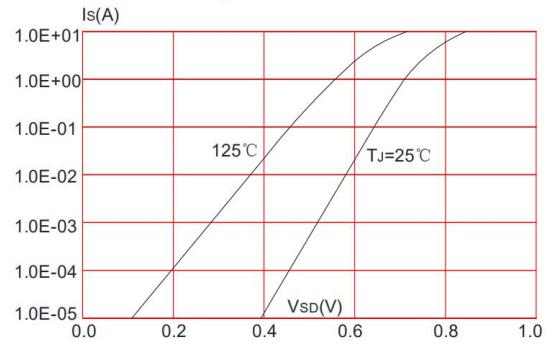


Figure 5: Gate Charge Characteristics

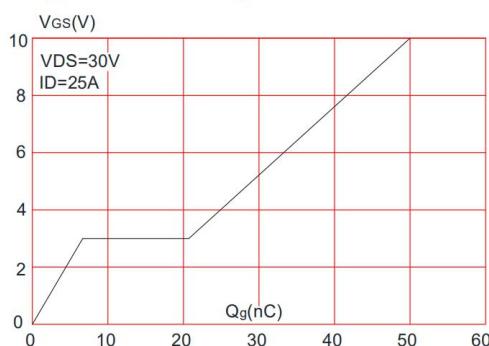
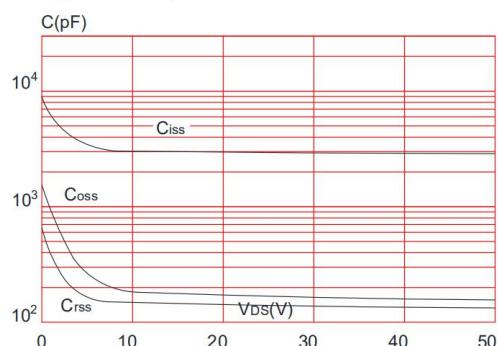


Figure 6: Capacitance Characteristics



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Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

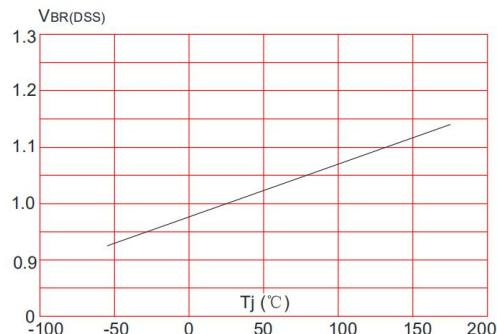


Figure 8: Normalized on Resistance vs. Junction Temperature

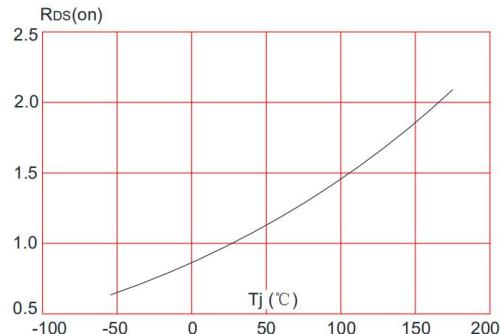


Figure 9: Maximum Safe Operating Area

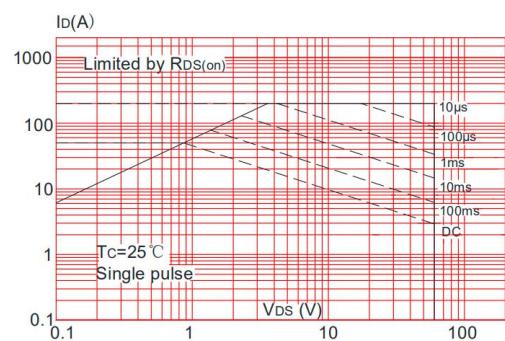


Figure 10: Maximum Continuous Drain Current vs. Case Temperature

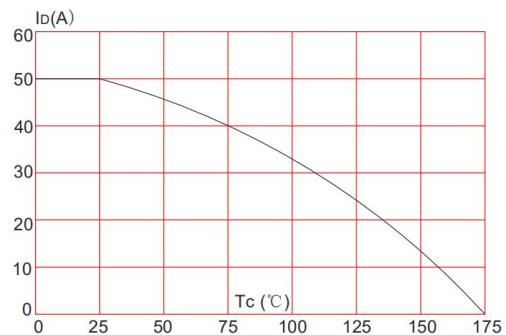
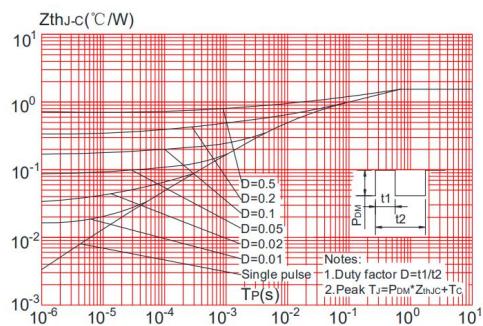


Figure 11: Maximum Effective Transient Thermal Impedance, Junction-to-Case



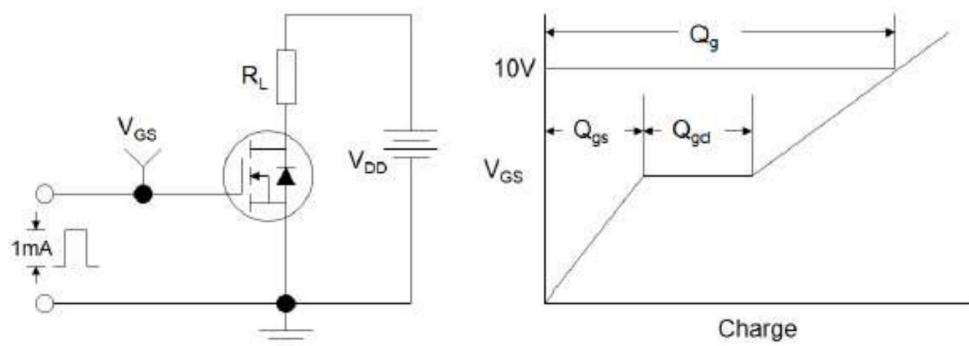
60V N-Channel Enhancement Mode Power MOSFET**Test Circuit**

Figure 1: Gate Charge Test Circuit & Waveform

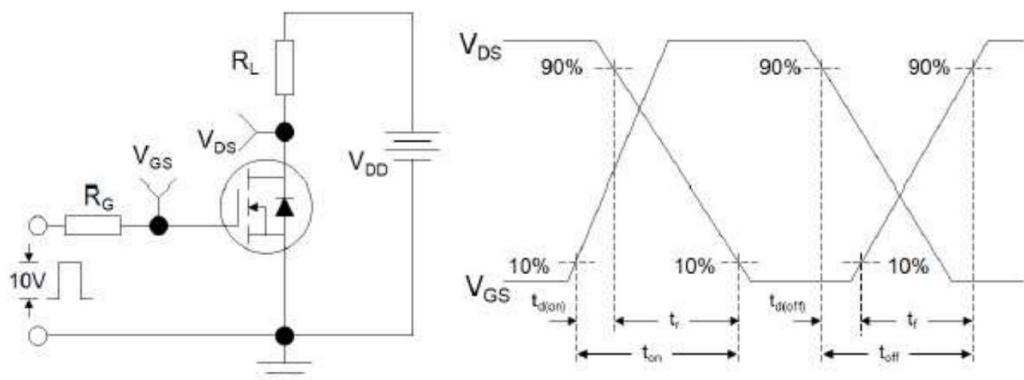


Figure 2: Resistive Switching Test Circuit & Waveforms

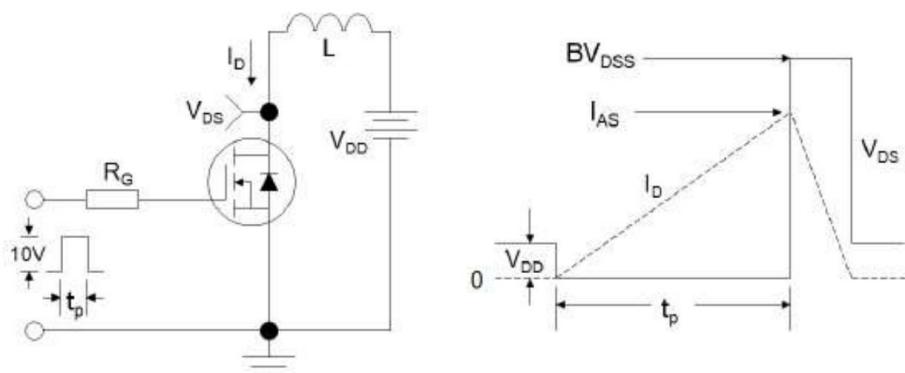
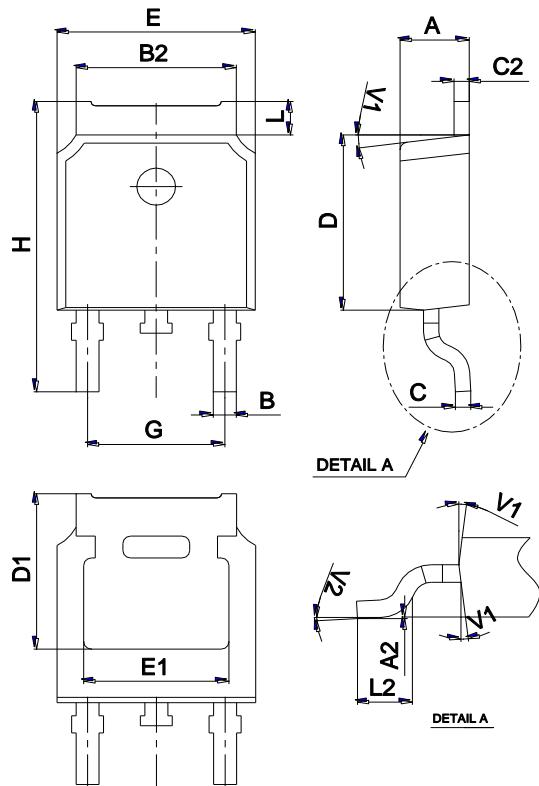


Figure 3: Unclamped Inductive Switching Test Circuit & Waveforms

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Package Mechanical Data TO-252



Ref.	Dimensions					
	Millimeters			Inches		
Min.	Typ.	Max.	Min.	Typ.	Max.	
A	2.10		2.50	0.083		0.098
A2	0		0.10	0		0.004
B	0.66		0.86	0.026		0.034
B2	5.18		5.48	0.202		0.216
C	0.40		0.60	0.016		0.024
C2	0.44		0.58	0.017		0.023
D	5.90		6.30	0.232		0.248
D1	5.30REF			0.209REF		
E	6.40		6.80	0.252		0.268
E1	4.63			0.182		
G	4.47		4.67	0.176		0.184
H	9.50		10.70	0.374		0.421
L	1.09		1.21	0.043		0.048
L2	1.35		1.65	0.053		0.065
V1		7°			7°	
V2	0°		6°	0°		6°

Ordering information

Order code	Package	Baseqty	Delivery mode
UMW STD35NF06L	TO-252	2500	Tape and reel

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[EFC2J004NUZTDG](#) [FCAB21350L1](#) [P85W28HP2F-7071](#) [DMN1053UCP4-7](#) [NTE2384](#) [NTE2969](#) [NTE6400A](#) [DMC2700UDMQ-7](#)
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